


<b><i>Search Notes</i></b>  	<b>Application/Control No.</b>  10791504	<b>Applicant(s)/Patent Under Reexamination</b>  CHIANG ET AL.
	<b>Examiner</b>  ANISH DESAI	<b>Art Unit</b>  1794

SEARCHED			
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SEARCH NOTES		
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